

**FEATURES**

- Circular Active Area
- Ideal for EUV Detection
- 100% Internal Quantum Efficiency
- Higher Overall Responsivity
- Lower Noise
- Superior Radiation Hardness
- High Photon Flux Robustness
- TO-8 Package

**ELECTRO-OPTICAL CHARACTERISTICS AT 25°C**

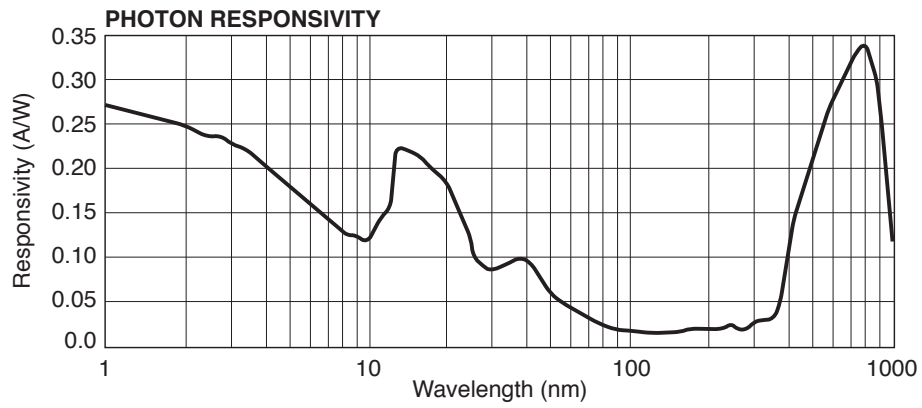
PARAMETERS	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Active Area <sup>1</sup>	Ø5.01mm		20		mm <sup>2</sup>
Responsivity, $\mathcal{R}$	(see graph on next page)				A/W
Reverse Breakdown Voltage, $V_R$	$I_R = 1\mu A$	5	10		Volts
Capacitance, C	$V_R = 0V$		1.55	3	nF
Rise Time	$RL = 50\Omega, V_R = 0V$		2		usec
Shunt Resistance	$V_f = \pm 10mV$	50	200		MOhms

<sup>1</sup>Die Active Area = Ø5.5mm, Aperture Size = Ø4.9mm.

**THERMAL PARAMETERS**

Storage Temperature Range	-20°C TO 100°C
Operating Temperature Range	-20° TO 80°C <sup>2</sup>
Maximum Junction Temperature	100°C
Lead Soldering Temperature <sup>2</sup>	260°C

<sup>2</sup>1/16" from case for 10 seconds.



**Ordering Information**

SXUV20C ODD-SXU-051 Low Noise EUV Detector in TO8 Package